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Applications of "[Embedded - Microcontrollers](#)"

Details

Product Status	Active
Core Processor	e200z4
Core Size	32-Bit Single-Core
Speed	120MHz
Connectivity	CANbus, Ethernet, FlexRay, I ² C, LINbus, SPI
Peripherals	DMA, I ² S, POR, WDT
Number of I/O	129
Program Memory Size	3MB (3M x 8)
Program Memory Type	FLASH
EEPROM Size	64K x 8
RAM Size	384K x 8
Voltage - Supply (Vcc/Vdd)	3.15V ~ 5.5V
Data Converters	A/D 36x10b, 16x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 125°C (TA)
Mounting Type	Surface Mount
Package / Case	176-LQFP Exposed Pad
Supplier Device Package	176-LQFP (24x24)
Purchase URL	https://www.e-xfl.com/pro/item?MUrl=&PartUrl=spc5746bsk1mku2

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Table 1. MPC5746C Family Comparison¹ (continued)

Feature	MPC5745B	MPC5744B	MPC5746B	MPC5744C	MPC5745C	MPC5746C
I ² C	4	4	4		4	
SAI/I ² S	3	3	3		3	
FXOSC	8 - 40 MHz					
SXOSC	32 KHz					
FIRC	16 MHz					
SIRC	128 KHz					
FMPLL	1					
Low Power Unit (LPU)	Yes					
FlexRay 2.1 (dual channel)	Yes, 128 MB	Yes, 128 MB	Yes, 128 MB		Yes, 128 MB	
Ethernet (RMII, MII + 1588, Multi queue AVB support)	1	1	1		1	
CRC	1					
MEMU	2					
STCU2	1					
HSM-v2 (security)	Optional					
Censorship	Yes					
FCCU	1					
Safety level	Specific functions ASIL-B certifiable					
User MBIST	Yes					
I/O Retention in Standby	Yes					
GPIO ⁶	Up to 264 GPI and up to 246 GPIO					
Debug	JTAGC, cJTAG					
Nexus	Z4 N3+ (Only available on 324BGA (development only)) Z2 N3+ (Only available on 324BGA (development only))					
Packages	176 LQFP-EP 256 BGA 100 BGA	176 LQFP-EP 256 BGA 100 BGA	176 LQFP-EP 256 BGA 100 BGA	176 LQFP-EP 256 BGA 100 BGA	176 LQFP-EP 256 BGA 100 BGA	176 LQFP-EP 256 BGA, 324 BGA (development only) 100 BGA

1. Feature set dependent on selected peripheral multiplexing, table shows example. Peripheral availability is package dependent.
2. Based on 125°C ambient operating temperature and subject to full device characterization.
3. Contact NXP representative for part number
4. Additional SWT included when HSM option selected
5. See device datasheet and reference manual for information on to timer channel configuration and functions.
6. Estimated I/O count for largest proposed packages based on multiplexing with peripherals.

4.2 Recommended operating conditions

The following table describes the operating conditions for the device, and for which all specifications in the data sheet are valid, except where explicitly noted. The device operating conditions must not be exceeded in order to guarantee proper operation and reliability. The ranges in this table are design targets and actual data may vary in the given range.

NOTE

- For normal device operations, all supplies must be within operating range corresponding to the range mentioned in following tables. This is required even if some of the features are not used.
- If VDD_HV_A is in 3.3V range, VDD_HV_FLA should be externally supplied using a 3.3V source. If VDD_HV_A is in 5V range, VDD_HV_FLA should be shorted to VDD_HV_A.
- VDD_HV_A, VDD_HV_B and VDD_HV_C are all independent supplies and can each be set to 3.3V or 5V. The following tables: 'Recommended operating conditions (VDD_HV_x = 3.3 V)' and table 'Recommended operating conditions (VDD_HV_x = 5 V)' specify their ranges when configured in 3.3V or 5V respectively.

Table 6. Recommended operating conditions (V_{DD_HV_x} = 3.3 V)

Symbol	Parameter	Conditions ¹	Min ²	Max	Unit
V _{DD_HV_A} V _{DD_HV_B} V _{DD_HV_C}	HV IO supply voltage	—	3.15	3.6	V
V _{DD_HV_FLA} ³	HV flash supply voltage	—	3.15	3.6	V
V _{DD_HV_ADC1_REF}	HV ADC1 high reference voltage	—	3.0	5.5	V
V _{DD_HV_ADC0} V _{DD_HV_ADC1}	HV ADC supply voltage	—	max(V _{DD_HV_A} , V _{DD_HV_B} , V _{DD_HV_C}) - 0.05	3.6	V
V _{SS_HV_ADC0} V _{SS_HV_ADC1}	HV ADC supply ground	—	-0.1	0.1	V
V _{DD_LV} ^{4, 5}	Core supply voltage	—	1.2	1.32	V
V _{IN1_CMP_REF} ^{6, 7}	Analog Comparator DAC reference voltage	—	3.15	3.6	V
I _{INJPAD}	Injected input current on any pin during overload condition	—	-3.0	3.0	mA

Table continues on the next page...

Table 6. Recommended operating conditions ($V_{DD_HV_x} = 3.3\text{ V}$) (continued)

Symbol	Parameter	Conditions ¹	Min ²	Max	Unit
T_A ⁸	Ambient temperature under bias	$f_{CPU} \leq 160\text{ MHz}$	-40	125	°C
T_J	Junction temperature under bias	—	-40	150	°C

- All voltages are referred to V_{SS_HV} unless otherwise specified
- Device will be functional down (and electrical specifications as per various datasheet parameters will be guaranteed) to the point where one of the LVD/HVD resets the device. When voltage drops outside range for an LVD/HVD, device is reset.
- $V_{DD_HV_FLA}$ must be connected to $V_{DD_HV_A}$ when $V_{DD_HV_A} = 3.3\text{V}$
- Only applicable when supplying from external source.
- V_{DD_LV} supply pins should never be grounded (through a small impedance). If these are not driven, they should only be left floating.
- $V_{IN1_CMP_REF} \leq V_{DD_HV_A}$
- This supply is shorted $V_{DD_HV_A}$ on lower packages.
- $T_J = 150^\circ\text{C}$. Assumes $T_A = 125^\circ\text{C}$
 - Assumes maximum θ_{JA} of 2s2p board. See [Thermal attributes](#)

NOTE

If $V_{DD_HV_A}$ is in 5V range, it is necessary to use internal Flash supply 3.3V regulator. $V_{DD_HV_FLA}$ should not be supplied externally and should only have decoupling capacitor.

Table 7. Recommended operating conditions ($V_{DD_HV_x} = 5\text{ V}$)

Symbol	Parameter	Conditions ¹	Min ²	Max	Unit
$V_{DD_HV_A}$ $V_{DD_HV_B}$ $V_{DD_HV_C}$	HV IO supply voltage	—	4.5	5.5	V
$V_{DD_HV_FLA}$ ³	HV flash supply voltage	—	3.15	3.6	V
$V_{DD_HV_ADC1_REF}$	HV ADC1 high reference voltage	—	3.15	5.5	V
$V_{DD_HV_ADC0}$ $V_{DD_HV_ADC1}$	HV ADC supply voltage	—	$\max(V_{DD_H_V_A}, V_{DD_H_V_B}, V_{DD_H_V_C}) - 0.05$	5.5	V
$V_{SS_HV_ADC0}$ $V_{SS_HV_ADC1}$	HV ADC supply ground	—	-0.1	0.1	V
V_{DD_LV} ⁴	Core supply voltage	—	1.2	1.32	V
$V_{IN1_CMP_REF}$ ^{5,6}	Analog Comparator DAC reference voltage	—	3.15	5.5 ⁵	V
I_{INJPAD}	Injected input current on any pin during overload condition	—	-3.0	3.0	mA
T_A ⁷	Ambient temperature under bias	$f_{CPU} \leq 160\text{ MHz}$	-40	125	°C
T_J	Junction temperature under bias	—	-40	150	°C

- All voltages are referred to V_{SS_HV} unless otherwise specified
- Device will be functional down (and electrical specifications as per various datasheet parameters will be guaranteed) to the point where one of the LVD/HVD resets the device. When voltage drops outside range for an LVD/HVD, device is reset.
- When V_{DD_HV} is in 5 V range, $V_{DD_HV_FLA}$ cannot be supplied externally. This pin is decoupled with C_{flash_reg} .

Table 10. Current consumption characteristics (continued)

Symbol	Parameter	Conditions ¹	Min	Typ	Max	Unit
$I_{DD_HV_ADC_REF}$ ^{10, 11, 11}	ADC REF Operating current	$T_a = 125\text{ }^\circ\text{C}$ ⁵ 2 ADCs operating at 80 MHz $V_{DD_HV_ADC_REF} = 5.5\text{ V}$	—	200	400	μA
		$T_a = 105\text{ }^\circ\text{C}$ 2 ADCs operating at 80 MHz $V_{DD_HV_ADC_REF} = 5.5\text{ V}$	—	200	—	
		$T_a = 85\text{ }^\circ\text{C}$ 2 ADCs operating at 80 MHz $V_{DD_HV_ADC_REF} = 5.5\text{ V}$	—	200	—	
		$T_a = 25\text{ }^\circ\text{C}$ 2 ADCs operating at 80 MHz $V_{DD_HV_ADC_REF} = 3.6\text{ V}$	—	200	—	
$I_{DD_HV_ADCx}$ ¹¹	ADC HV Operating current	$T_a = 125\text{ }^\circ\text{C}$ ⁵ ADC operating at 80 MHz $V_{DD_HV_ADC} = 5.5\text{ V}$	—	1.2	2	mA
		$T_a = 25\text{ }^\circ\text{C}$ ADC operating at 80 MHz $V_{DD_HV_ADC} = 3.6\text{ V}$	—	1	2	
$I_{DD_HV_FLASH}$ ¹²	Flash Operating current during read access	$T_a = 125\text{ }^\circ\text{C}$ ⁵ 3.3 V supplies 160 MHz frequency	—	40	45	mA
		$T_a = 105\text{ }^\circ\text{C}$ 3.3 V supplies 160 MHz frequency	—	40	45	
		$T_a = 85\text{ }^\circ\text{C}$ 3.3 V supplies 160 MHz frequency	—	40	45	

- The content of the Conditions column identifies the components that draw the specific current.
- Single e200Z4 core cache disabled @80 MHz, no FlexRay, no ENET, 2 x CAN, 8 LINFlexD, 2 SPI, ADC0 and 1 used constantly, no HSM, Memory: 2M flash, 128K RAM RUN mode, Clocks: FIRC on, XOSC, PLL on, SIRC on for TOD, no 32KHz crystal (TOD runs off SIRC).
- Recommended Transistors:MJD31 @ 85°C, 105°C and 125°C. In case of internal ballast mode, it is expected that the external ballast is not mounted and BAL_SELECT_INT pin is tied to VDD_HV_A supply on board. Internal ballast can be used for all use cases with current consumption upto 150mA
- The power consumption does not consider the dynamic current of I/Os
- $T_j=150\text{ }^\circ\text{C}$. Assumes $T_a=125\text{ }^\circ\text{C}$
 - Assumes maximum θ_{JA} of 2s2p board. See [Thermal attributes](#)
- e200Z4 core, 160MHz, cache enabled; e200Z2 core , 80MHz, no FlexRay, no ENET, 7 CAN, 16 LINFlexD, 4 SPI, 1x ADC used constantly, includes HSM at start-up / periodic use, Memory: 3M flash, 256K RAM, Clocks: FIRC on, XOSC on, PLL on, SIRC on, no 32KHz crystal
- e200Z4 core, 120MHz, cache enabled; e200Z2 core, 60MHz; no FlexRay, no ENET, 7 CAN, 16 LINFlexD, 4 SPI, 1x ADC used constantly, includes HSM at start-up / periodic use, Memory: 3M flash, 128K RAM, Clocks: FIRC on, XOSC on, PLL on, SIRC on, no 32KHz crystal

Table 17. DC electrical specifications @ 5 V Range (continued)

Symbol	Parameter	Value		Unit
		Min	Max	
Vil (pad_i_hv)	pad_i_hv Input Buffer Low Voltage	$VDD_HV_x - 0.3$	$0.45 \cdot VDD_HV_x$	V
Vhys (pad_i_hv)	pad_i_hv Input Buffer Hysteresis	$0.09 \cdot VDD_HV_x$		V
Vih_hys	CMOS Input Buffer High Voltage (with hysteresis enabled)	$0.65 \cdot VDD_HV_x$	$VDD_HV_x + 0.3$	V
Vil_hys	CMOS Input Buffer Low Voltage (with hysteresis enabled)	$VDD_HV_x - 0.3$	$0.35 \cdot VDD_HV_x$	V
Vih	CMOS Input Buffer High Voltage (with hysteresis disabled)	$0.55 \cdot VDD_HV_x^{1,1}$	$VDD_HV_x^{1,1} + 0.3$	V
Vil	CMOS Input Buffer Low Voltage (with hysteresis disabled)	$VDD_HV_x - 0.3$	$0.40 \cdot VDD_HV_x^{1,1}$	V
Vhys	CMOS Input Buffer Hysteresis	$0.09 \cdot VDD_HV_x^{1,1}$		V
Pull_IIH (pad_i_hv)	Weak Pullup Current ^{2,2} Low	23		μA
Pull_IIH (pad_i_hv)	Weak Pullup Current ^{3,3} High		82	μA
Pull_IIL (pad_i_hv)	Weak Pulldown Current ³ Low	40		μA
Pull_IIL (pad_i_hv)	Weak Pulldown Current ² High		130	μA
Pull_loh	Weak Pullup Current ⁴	30	80	μA
Pull_lol	Weak Pulldown Current ⁵	30	80	μA
Iinact_d	Digital Pad Input Leakage Current (weak pull inactive)	-2.5	2.5	μA
Voh	Output High Voltage ⁶	$0.8 \cdot VDD_HV_x^{1,1}$	—	V
Vol	Output Low Voltage ⁷ Output Low Voltage ⁸	—	$0.2 \cdot VDD_HV_x$ $0.1 \cdot VDD_HV_x$	V
Ioh_f	Full drive Ioh ^{9,9} (SIUL2_MSCRn.SRC[1:0] = 11)	18	70	mA
Iol_f	Full drive Iol ⁹ (SIUL2_MSCRn.SRC[1:0] = 11)	21	120	mA
Ioh_h	Half drive Ioh ⁹ (SIUL2_MSCRn.SRC[1:0] = 10)	9	35	mA
Iol_h	Half drive Iol ⁹ (SIUL2_MSCRn.SRC[1:0] = 10)	10.5	60	mA

1. $VDD_HV_x = VDD_HV_A, VDD_HV_B, VDD_HV_C$
2. Measured when $pad = 0.69 \cdot VDD_HV_x$
3. Measured when $pad = 0.49 \cdot VDD_HV_x$
4. Measured when $pad = 0 V$
5. Measured when $pad = VDD_HV_x$
6. Measured when pad is sourcing 2 mA
7. Measured when pad is sinking 2 mA
8. Measured when pad is sinking 1.5 mA
9. Ioh/Iol is derived from spice simulations. These values are NOT guaranteed by test.

5.5 Reset pad electrical characteristics

The device implements a dedicated bidirectional RESET pin.

6.1.1.1 Input equivalent circuit and ADC conversion characteristics

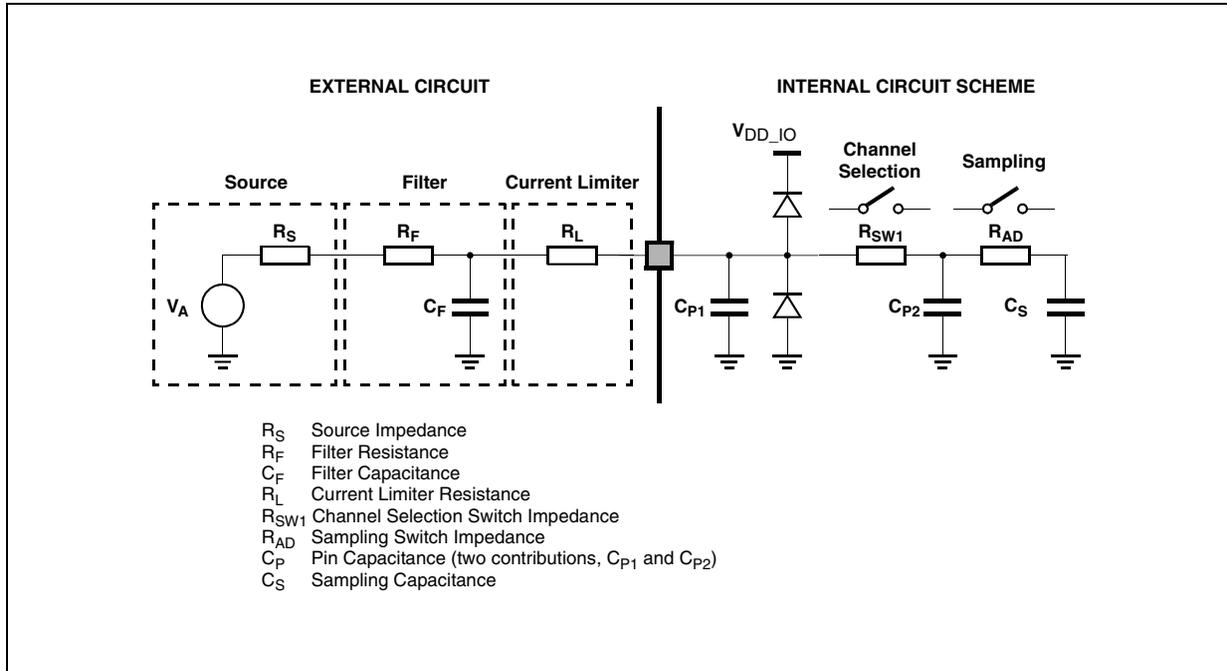


Figure 6. Input equivalent circuit

NOTE

The ADC performance specifications are not guaranteed if two ADCs simultaneously sample the same shared channel.

Table 20. ADC conversion characteristics (for 12-bit)

Symbol	Parameter	Conditions	Min	Typ ¹	Max	Unit
f_{CK}	ADC Clock frequency (depends on ADC configuration) (The duty cycle depends on AD_CK ² frequency)	—	15.2	80	80	MHz
f_s	Sampling frequency	80 MHz	—	—	1.00	MHz
t_{sample}	Sample time ³	80 MHz @ 100 ohm source impedance	250	—	—	ns
t_{conv}	Conversion time ⁴	80 MHz	700	—	—	ns
t_{total_conv}	Total Conversion time $t_{sample} + t_{conv}$ (for standard and extended channels)	80 MHz	1.5 ⁵	—	—	μ s
	Total Conversion time $t_{sample} + t_{conv}$ (for precision channels)		1	—	—	
$C_S^{6,6}$	ADC input sampling capacitance	—	—	3	5	pF
C_{P1}^6	ADC input pin capacitance 1	—	—	—	5	pF
C_{P2}^6	ADC input pin capacitance 2	—	—	—	0.8	pF
R_{SW1}^6	Internal resistance of analog source	V_{REF} range = 4.5 to 5.5 V	—	—	0.3	k Ω
		V_{REF} range = 3.15 to 3.6 V	—	—	875	Ω

Table continues on the next page...

Table 20. ADC conversion characteristics (for 12-bit) (continued)

Symbol	Parameter	Conditions	Min	Typ ¹	Max	Unit
R _{AD} ⁶	Internal resistance of analog source	—	—	—	825	Ω
INL	Integral non-linearity (precise channel)	—	-2	—	2	LSB
INL	Integral non-linearity (standard channel)	—	-3	—	3	LSB
DNL	Differential non-linearity	—	-1	—	1	LSB
OFS	Offset error	—	-6	—	6	LSB
GNE	Gain error	—	-4	—	4	LSB
ADC Analog Pad (pad going to one ADC)	Max leakage (precision channel)	150 °C	—	—	250	nA
	Max leakage (standard channel)	150 °C	—	—	2500	nA
	Max leakage (standard channel)	105 °C T _A	—	5	250	nA
	Max positive/negative injection		-5	—	5	mA
TUE _{precision channels}	Total unadjusted error for precision channels	Without current injection	-6	+/-4	6	LSB
		With current injection ^{7, 7}		+/-5		LSB
TUE _{standard/extended channels}	Total unadjusted error for standard/extended channels	Without current injection	-8	+/-6	8	LSB
		With current injection ⁷		+/-8		LSB
t _{recovery}	STOP mode to Run mode recovery time				< 1	μs

- Active ADC input, VinA < [min(ADC_VrefH, ADC_ADV, VDD_HV_IOx)]. VDD_HV_IOx refers to I/O segment supply voltage. Violation of this condition would lead to degradation of ADC performance. Please refer to Table: 'Absolute maximum ratings' to avoid damage. Refer to Table: 'Recommended operating conditions (VDD_HV_x = 3.3 V)' for required relation between IO_supply_A,B,C and ADC_Supply.
- The internally generated clock (known as AD_clk or ADCK) could be same as the peripheral clock or half of the peripheral clock based on register configuration in the ADC.
- During the sample time the input capacitance C_S can be charged/discharged by the external source. The internal resistance of the analog source must allow the capacitance to reach its final voltage level within t_{sample}. After the end of the sample time t_{sample}, changes of the analog input voltage have no effect on the conversion result. Values for the sample clock t_{sample} depend on programming.
- This parameter does not include the sample time t_{sample}, but only the time for determining the digital result and the time to load the result register with the conversion result.
- Apart from t_{sample} and t_{conv}, few cycles are used up in ADC digital interface and hence the overall throughput from the ADC is lower.
- See [Figure 6](#).
- Current injection condition for ADC channels is defined for an inactive ADC channel (on which conversion is NOT being performed), and this occurs when voltage on the ADC pin exceeds the I/O supply or ground. However, absolute maximum voltage spec on pad input (VINA, see Table: Absolute maximum ratings) must be honored to meet TUE spec quoted here

Table 21. ADC conversion characteristics (for 10-bit)

Symbol	Parameter	Conditions	Min	Typ ¹	Max	Unit
f _{CK}	ADC Clock frequency (depends on ADC configuration) (The duty cycle depends on AD_CK ² frequency.)	—	15.2	80	80	MHz
f _s	Sampling frequency	—	—	—	1.00	MHz
t _{sample}	Sample time ³	80 MHz @ 100 ohm source impedance	275	—	—	ns

Table continues on the next page...

6.1.2 Analog Comparator (CMP) electrical specifications

Table 22. Comparator and 6-bit DAC electrical specifications

Symbol	Description	Min.	Typ.	Max.	Unit
I_{DDHS}	Supply current, High-speed mode (EN=1, PMODE=1)	—	—	250	μA
$I_{DDL S}$	Supply current, low-speed mode (EN=1, PMODE=0)	—	5	11	μA
V_{AIN}	Analog input voltage	V_{SS}	—	$V_{IN1_CMP_REF}$	V
V_{AIO}	Analog input offset voltage ^{1, 1}	-47	—	47	mV
V_H	Analog comparator hysteresis ^{2, 2} <ul style="list-style-type: none"> • CR0[HYSTCTR] = 00 • CR0[HYSTCTR] = 01 • CR0[HYSTCTR] = 10 • CR0[HYSTCTR] = 11 	—	1	25	mV
		—	20	50	mV
		—	40	70	mV
		—	60	105	mV
		—	—	—	—
t_{DHS}	Propagation Delay, High Speed Mode (Full Swing) ^{1, 3, 3}	—	—	250	ns
t_{DLS}	Propagation Delay, Low power Mode (Full Swing) ^{1, 3}	—	5	21	μs
	Analog comparator initialization delay, High speed mode ^{4, 4}	—	4		μs
	Analog comparator initialization delay, Low speed mode ⁴	—	100		μs
I_{DAC6b}	6-bit DAC current adder (when enabled)				
	3.3V Reference Voltage	—	6	9	μA
	5V Reference Voltage	—	10	16	μA
INL	6-bit DAC integral non-linearity	-0.5	—	0.5	LSB ⁵
DNL	6-bit DAC differential non-linearity	-0.8	—	0.8	LSB

1. Measured with hysteresis mode of 00
2. Typical hysteresis is measured with input voltage range limited to 0.6 to $V_{DD_HV_A}-0.6\text{V}$
3. Full swing = V_{IH} , V_{IL}
4. Comparator initialization delay is defined as the time between software writes to change control inputs (Writes to DACEN, VRSEL, PSEL, MSEL, VOSEL) and the comparator output settling to a stable level.
5. 1 LSB = $V_{reference}/64$

NOTE

The above start up time of 1 us is equivalent to 16 cycles of 16 MHz.

6.2.4 128 KHz Internal RC oscillator Electrical specifications**Table 26. 128 KHz Internal RC oscillator electrical specifications**

Symbol	Parameter	Condition	Min	Typ	Max	Unit
F_{oscu}^1	Oscillator frequency	Calibrated	119	128	136.5	KHz
	Temperature dependence				600	ppm/C
	Supply dependence				18	%/V
	Supply current	Clock running			2.75	μA
		Clock stopped			200	nA

1. $V_{\text{dd}}=1.2\text{ V}$, 1.32V , $T_{\text{a}}=-40\text{ C}$, 125 C

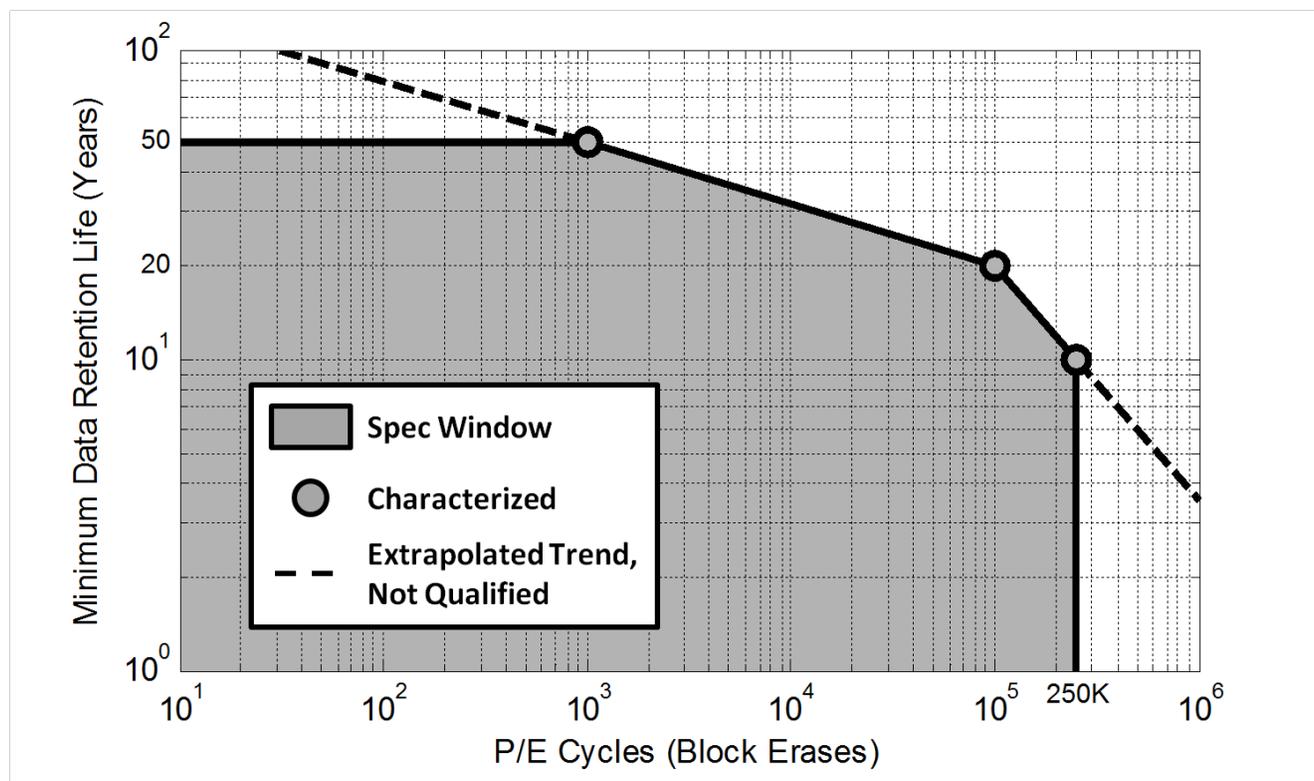
6.2.5 PLL electrical specifications**Table 27. PLL electrical specifications**

Parameter	Min	Typ	Max	Unit	Comments
Input Frequency	8		40	MHz	
VCO Frequency Range	600		1280	MHz	
Duty Cycle at pllclkout	48%		52%		This specification is guaranteed at PLL IP boundary
Period Jitter			See Table 28	ps	NON SSCG mode
TIE			See Table 28		at 960 M Integrated over 1MHz offset not valid in SSCG mode
Modulation Depth (Center Spread)	+/- 0.25%		+/- 3.0%		
Modulation Frequency			32	KHz	
Lock Time			60	μs	Calibration mode

Table 28. Jitter calculation

Type of jitter	Jitter due to Supply Noise (ps) J_{SN}^1	Jitter due to Fractional Mode (ps) J_{SDM}^2	Jitter due to Fractional Mode J_{SSCG}^3 (ps)	1 Sigma Random Jitter J_{RJ}^4 (ps)	Total Period Jitter (ps)
Period Jitter	60 ps	3% of pllclkout1,2	Modulation depth	0.1% of pllclkout1,2	$\pm(J_{\text{SN}}+J_{\text{SDM}}+J_{\text{SSCG}}+N^{[4]} \times J_{\text{RJ}})$

Table continues on the next page...



6.3.5 Flash memory AC timing specifications

Table 33. Flash memory AC timing specifications

Symbol	Characteristic	Min	Typical	Max	Units
t_{psus}	Time from setting the MCR-PSUS bit until MCR-DONE bit is set to a 1.	—	9.4 plus four system clock periods	11.5 plus four system clock periods	μ s
t_{esus}	Time from setting the MCR-ESUS bit until MCR-DONE bit is set to a 1.	—	16 plus four system clock periods	20.8 plus four system clock periods	μ s
t_{res}	Time from clearing the MCR-ESUS or PSUS bit with EHV = 1 until DONE goes low.	—	—	100	ns
t_{done}	Time from 0 to 1 transition on the MCR-EHV bit initiating a program/erase until the MCR-DONE bit is cleared.	—	—	5	ns
t_{dones}	Time from 1 to 0 transition on the MCR-EHV bit aborting a program/erase until the MCR-DONE bit is set to a 1.	—	16 plus four system clock periods	20.8 plus four system clock periods	μ s

Table continues on the next page...

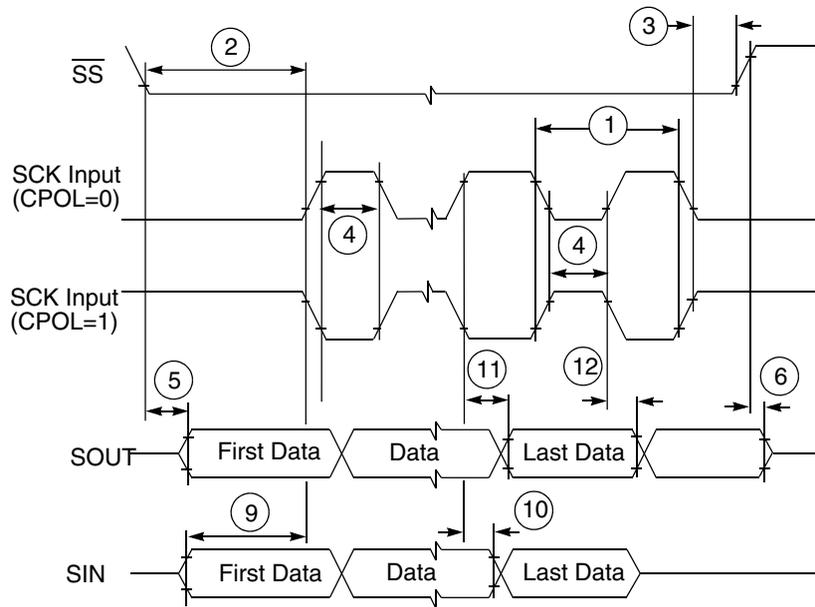


Figure 14. DSPI modified transfer format timing – slave, CPHA = 0

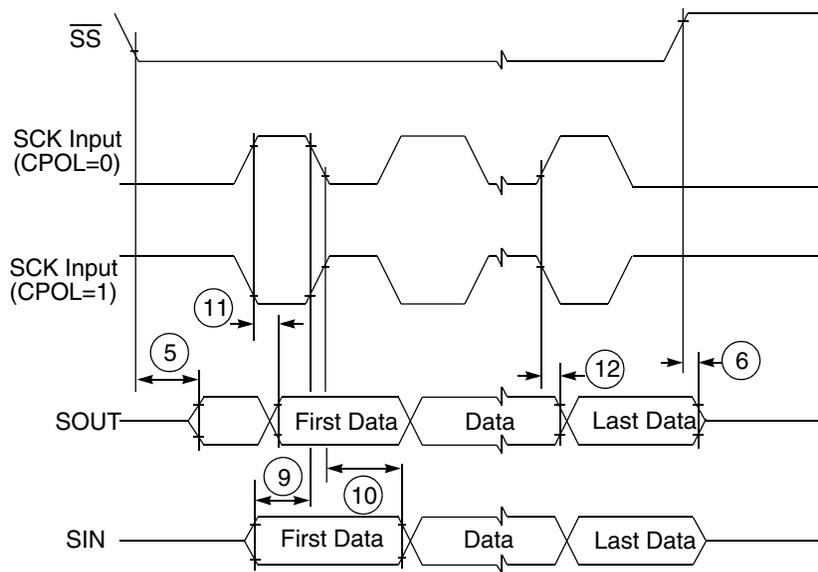


Figure 15. DSPI modified transfer format timing — slave, CPHA = 1

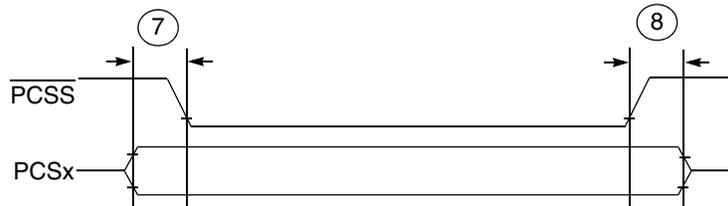


Figure 16. DSPI PCS strobe (PCSS) timing

6.4.2 FlexRay electrical specifications

6.4.2.1 FlexRay timing

This section provides the FlexRay Interface timing characteristics for the input and output signals. It should be noted that these are recommended numbers as per the FlexRay EPL v3.0 specification, and subject to change per the final timing analysis of the device.

6.4.2.2 TxEN

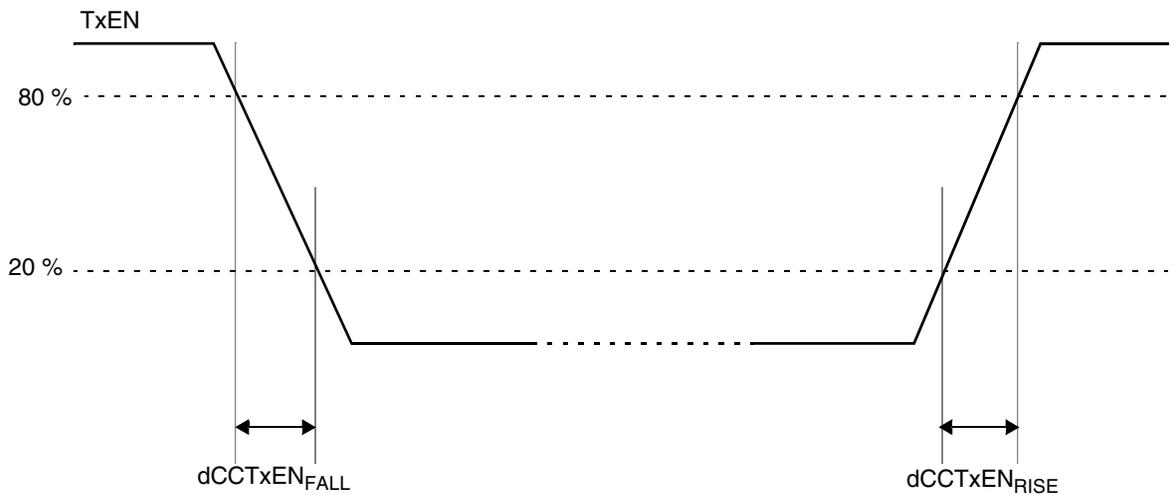


Figure 17. TxEN signal

Table 38. TxEN output characteristics¹

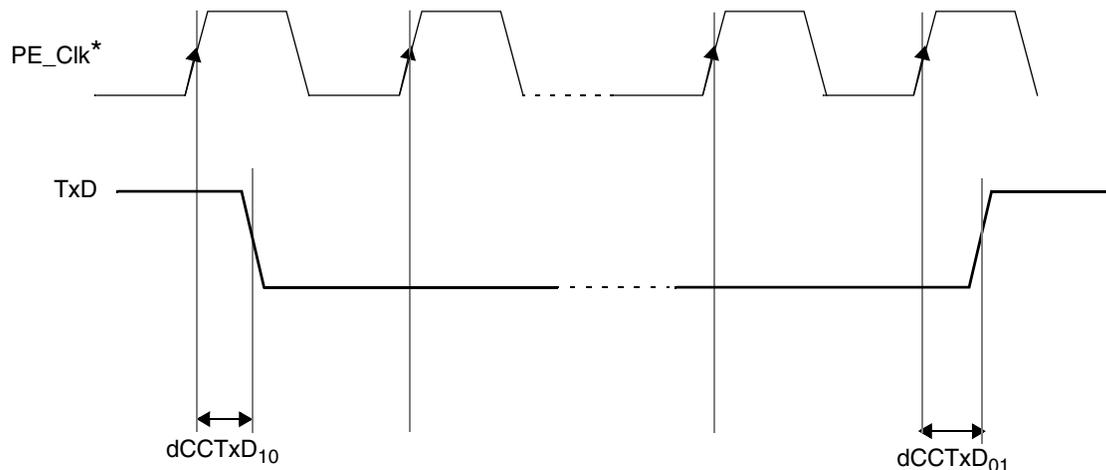
Name	Description	Min	Max	Unit
dCCTxEN _{RISE25}	Rise time of TxEN signal at CC	—	9	ns
dCCTxEN _{FALL25}	Fall time of TxEN signal at CC	—	9	ns
dCCTxEN ₀₁	Sum of delay between Clk to Q of the last FF and the final output buffer, rising edge	—	25	ns
dCCTxEN ₁₀	Sum of delay between Clk to Q of the last FF and the final output buffer, falling edge	—	25	ns

1. All parameters specified for $V_{DD_HV_IOx} = 3.3\text{ V} -5\%, \pm 10\%$, $T_J = -40\text{ }^\circ\text{C} / 150\text{ }^\circ\text{C}$, TxEN pin load maximum 25 pF

Table 39. TxD output characteristics (continued)

Name	Description ¹	Min	Max	Unit
dCCTxD ₀₁	Sum of delay between Clk to Q of the last FF and the final output buffer, rising edge	—	25	ns
dCCTxD ₁₀	Sum of delay between Clk to Q of the last FF and the final output buffer, falling edge	—	25	ns

- All parameters specified for $V_{DD_HV_IOx} = 3.3\text{ V} -5\%, \pm 10\%$, $T_J = -40\text{ }^\circ\text{C} / 150\text{ }^\circ\text{C}$, TxD pin load maximum 25 pF.
- For 3.3 V \pm 10% operation, this specification is 10 ns.



*FlexRay Protocol Engine Clock

Figure 20. TxD Signal propagation delays

6.4.2.4 RxD

Table 40. RxD input characteristic

Name	Description ¹	Min	Max	Unit
C_CCRxD	Input capacitance on RxD pin	—	7	pF
uCCLogic_1	Threshold for detecting logic high	35	70	%
uCCLogic_0	Threshold for detecting logic low	30	65	%
dCCRxD ₀₁	Sum of delay from actual input to the D input of the first FF, rising edge	—	10	ns
dCCRxD ₁₀	Sum of delay from actual input to the D input of the first FF, falling edge	—	10	ns

1. All parameters specified for VDD_HV_IOx = 3.3 V -5%, ±10%, TJ = -40 oC / 150 oC.

6.4.3 Ethernet switching specifications

The following timing specs are defined at the chip I/O pin and must be translated appropriately to arrive at timing specs/constraints for the physical interface.

6.4.3.1 MII signal switching specifications

The following timing specs meet the requirements for MII style interfaces for a range of transceiver devices.

Table 41. MII signal switching specifications

Symbol	Description	Min.	Max.	Unit
—	RXCLK frequency	—	25	MHz
MII1	RXCLK pulse width high	35%	65%	RXCLK period
MII2	RXCLK pulse width low	35%	65%	RXCLK period
MII3	RXD[3:0], RXDV, RXER to RXCLK setup	5	—	ns
MII4	RXCLK to RXD[3:0], RXDV, RXER hold	5	—	ns
—	TXCLK frequency	—	25	MHz
MII5	TXCLK pulse width high	35%	65%	TXCLK period
MII6	TXCLK pulse width low	35%	65%	TXCLK period
MII7	TXCLK to TXD[3:0], TXEN, TXER invalid	2	—	ns
MII8	TXCLK to TXD[3:0], TXEN, TXER valid	—	25	ns

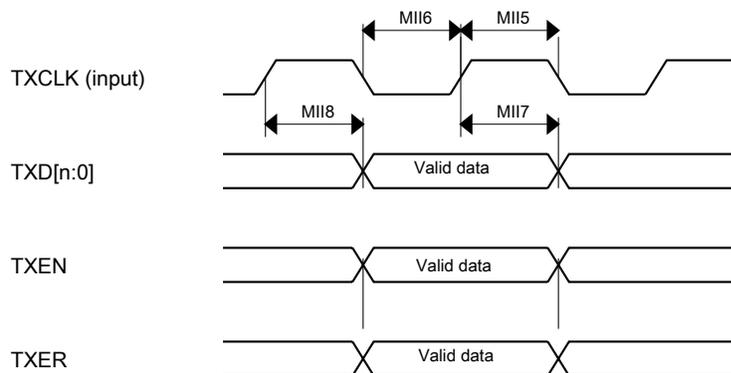


Figure 21. RMII/MII transmit signal timing diagram

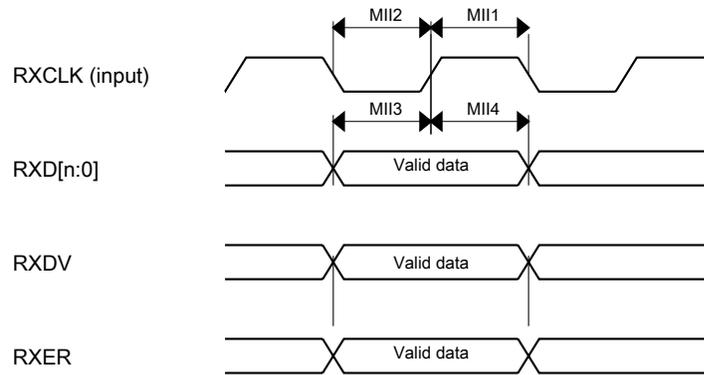


Figure 22. RMII/MII receive signal timing diagram

6.4.3.2 RMII signal switching specifications

The following timing specs meet the requirements for RMII style interfaces for a range of transceiver devices.

Table 42. RMII signal switching specifications

Num	Description	Min.	Max.	Unit
—	EXTAL frequency (RMII input clock RMII_CLK)	—	50	MHz
RMII1	RMII_CLK pulse width high	35%	65%	RMII_CLK period
RMII2	RMII_CLK pulse width low	35%	65%	RMII_CLK period
RMII3	RXD[1:0], CRS_DV, RXER to RMII_CLK setup	4	—	ns
RMII4	RMII_CLK to RXD[1:0], CRS_DV, RXER hold	2	—	ns
RMII7	RMII_CLK to TXD[1:0], TXEN invalid	4	—	ns
RMII8	RMII_CLK to TXD[1:0], TXEN valid	—	15	ns

6.4.4 SAI electrical specifications

All timing requirements are specified relative to the clock period or to the minimum allowed clock period of a device

Table 43. Master mode SAI Timing

no	Parameter	Value		Unit
		Min	Max	
	Operating Voltage	2.7	3.6	V
S1	SAI_MCLK cycle time	40	-	ns

Table continues on the next page...

Table 51. Revision History (continued)

Rev. No.	Date	Substantial Changes
Rev 2	7 August 2015	<ul style="list-style-type: none"> • In features: <ul style="list-style-type: none"> • Updated BAF feature with sentence, Boot Assist Flash (BAF) supports internal flash programming via a serial link (SCI) • Updated FlexCAN3 with FD support • Updated number of STMs to two. • In Block diagram: <ul style="list-style-type: none"> • Updated SRAM size from 128 KB to 256 KB. • In Family Comparison: <ul style="list-style-type: none"> • Added note: All optional features (Flash memory, RAM, Peripherals) start with lowest number or address (e.g. FlexCAN0) and end at highest available number or address (e.g. MPC574xB/D have 6 CAN, ending with FlexCAN5). • Revised MPC5746C Family Comparison table. • In Ordering parts: <ul style="list-style-type: none"> • Updated ordering parts diagram to include 100 MAPBGA information and optional fields. • In table: Absolute maximum ratings <ul style="list-style-type: none"> • Removed entry: 'V_{SS_HV}' • Added spec for 'V_{DD12}' • Updated 'Max' column for 'V_{INA}' • Updated footnote for V_{DD_HV_ADC1_REF}. • Added footnote to 'Conditions', All voltages are referred to V_{SS_HV} unless otherwise specified • Removed footnote from 'Max', Absolute maximum voltages are currently maximum burn-in voltages. Absolute maximum specifications for device stress have not yet been determined. • In section: Recommended operating conditions <ul style="list-style-type: none"> • Added opening text: "The following table describes the operating conditions ... " • Added note: "V_{DD_HV_A}, V_{DD_HV_B} and V_{DD_HV_C} are all ... " • In table: Recommended operating conditions (V_{DD_HV_x} = 3.3 V) and (V_{DD_HV_x} = 5 V) <ul style="list-style-type: none"> • Added footnote to 'Conditions' column, (All voltages are referred to V_{SS_HV} unless otherwise specified). • Updated footnote for 'Min' column to Device will be functional down (and electrical specifications as per various datasheet parameters will be guaranteed) to the point where one of the LVD/HVD resets the device. When voltage drops outside range for an LVD/HVD, device is reset. • Removed footnote for 'V_{DD_HV_A}', 'V_{DD_HV_B}', and 'V_{DD_HV_C}' entry and updated the parameter column. • Removed entry : 'V_{SS_HV}' • Updated 'Parameter' column for 'V_{DD_HV_FL_A}', 'V_{DD_HV_ADC1_REF}', 'V_{DD_LV}' • Updated 'Min' column for 'V_{DD_HV_ADC0}' 'V_{DD_HV_ADC1}' • Updated 'Parameter' 'Min' 'Max' columns for 'V_{SS_HV_ADC0}' and 'V_{SS_HV_ADC1}' • Updated footnote for 'V_{DD_LV}' to V_{DD_LV} supply pins should never be grounded (through a small impedance). If these are not driven, they should only be left floating. • Removed row for symbol 'V_{SS_LV}' • Removed footnote from 'Max' column of 'V_{DD_HV_ADC0}' and 'V_{DD_HV_ADC1}', (PA3, PA7, PA10, PA11 and PE12 ADC_1 channels are coming from V_{DD_HV_B} domain hence V_{DD_HV_ADC1} should be within ±100 mV of V_{DD_HV_B} when these channels are used for ADC_1). • In table: Recommended operating conditions (V_{DD_HV_x} = 3.3 V) <ul style="list-style-type: none"> • Removed footnote from 'V_{IN1_CMP_REF}', (Only applicable when supplying from external source). • In table: Recommended operating conditions (V_{DD_HV_x} = 5 V) <ul style="list-style-type: none"> • Added spec for 'V_{IN1_CMP_REF}' and corresponding footnotes.

Table continues on the next page...

Table 51. Revision History (continued)

Rev. No.	Date	Substantial Changes
		<ul style="list-style-type: none"> • In section: Voltage monitor electrical characteristics <ul style="list-style-type: none"> • Updated description for Low Voltage detector block. • Added note, BCP56, MCP68 and MJD31 are guaranteed ballasts. • In table: Voltage regulator electrical specifications <ul style="list-style-type: none"> • Added footnote, Ceramic X7R or X5R type with capacitance-temperature characteristics +/-15% of -55 degC to +125degC is recommended. The tolerance +/-20% is acceptable. • Revised table, Voltage monitor electrical characteristics
		<ul style="list-style-type: none"> • In section: Supply current characteristics <ul style="list-style-type: none"> • In table: Current consumption characteristics <ul style="list-style-type: none"> • I_{DD_BODY_4}: Updated SYS_CLK to 120 MHz. • I_{DD_BODY_4}: Updated Max for T_a= 105 °C and 85 °C) • I_{dd_STOP}: Added condition for T_a= 105 °C and removed Max value for T_a= 85 °C. • I_{DD_HV_ADC_REF}: Added condition for T_a= 105 °C and 85 °C and removed Max value for T_a= 25 °C. • I_{DD_HV_FLASH}: Added condition for T_a= 105 °C and 85 °C • In table: Low Power Unit (LPU) Current consumption characteristics <ul style="list-style-type: none"> • LPU_RUN and LPU_STOP: Added condition for T_a= 105 °C and 85 °C • In table: STANDBY Current consumption characteristics <ul style="list-style-type: none"> • Added condition for T_a= 105 °C and 85 °C for all entries. • In section: I/O parameters <ul style="list-style-type: none"> • In table: Functional Pad AC Specifications @ 3.3 V Range <ul style="list-style-type: none"> • Updated values for 'pad_sr_hv (output)' • In table: DC electrical specifications @ 3.3V Range <ul style="list-style-type: none"> • Updated Min and Max values for V_{ih} and V_{il} respectively. • In table: Functional Pad AC Specifications @ 5 V Range <ul style="list-style-type: none"> • Updated values for 'pad_sr_hv (output)' • In table DC electrical specifications @ 5 V Range <ul style="list-style-type: none"> • Updated Min value for V_{hys}

Table continues on the next page...

Table 51. Revision History (continued)

Rev. No.	Date	Substantial Changes
Rev 3	2 March 2016	<ul style="list-style-type: none"> • In section, Recommended operating conditions <ul style="list-style-type: none"> • Added a new Note • In section, Voltage regulator electrical characteristics <ul style="list-style-type: none"> • In table, Voltage regulator electrical specifications: <ul style="list-style-type: none"> • Added a new row for C_{HV_VDD_B} • Added a footnote on V_{DD_HV_BALLAST} • Added a new Note at the end of this section • In section, Voltage monitor electrical characteristics <ul style="list-style-type: none"> • In table, Voltage monitor electrical characteristics: <ul style="list-style-type: none"> • Removed "V_{LVD_FLASH}" and "V_{LVD_FLASH} during low power mode using LPBG as reference" rows • Updated Fall and Rise trimmed Minimum values for V_{HVD_LV_cold} • In section, Supply current characteristics <ul style="list-style-type: none"> • In table, Current consumption characteristics: <ul style="list-style-type: none"> • Updated the footnote mentioned in the Condition column of I_{DD_STOP} row • Updated all TBD values • In table, Low Power Unit (LPU) Current consumption characteristics: <ul style="list-style-type: none"> • Updated the typical value of LPU_STOP to 0.18 mA • Updated all TBD values • In table, STANDBY Current consumption characteristics: <ul style="list-style-type: none"> • Updated all TBD values • In section, AC specifications @ 3.3 V Range <ul style="list-style-type: none"> • In table, Functional Pad AC Specifications @ 3.3 V Range: <ul style="list-style-type: none"> • Updated Rise/Fall Edge values • In section, DC electrical specifications @ 3.3V Range <ul style="list-style-type: none"> • In table, DC electrical specifications @ 3.3V Range: <ul style="list-style-type: none"> • Updated Max value for Vol to 0.1 * VDD_HV_x • In section, AC specifications @ 5 V Range <ul style="list-style-type: none"> • In table, Functional Pad AC Specifications @ 5 V Range: <ul style="list-style-type: none"> • Updated Rise/Fall Edge values • In section, DC electrical specifications @ 5 V Range <ul style="list-style-type: none"> • In table, DC electrical specifications @ 5 V Range: <ul style="list-style-type: none"> • Updated Min and Max values for Pull_Ioh and Pull_Iol rows • Updated Max value for Vol to 0.1 * VDD_HV_x • In section, Reset pad electrical characteristics <ul style="list-style-type: none"> • In table, Functional reset pad electrical specifications: <ul style="list-style-type: none"> • Updated parameter column for V_{IH}, V_{IL} and V_{HYS} rows • Updated Min and Max values for V_{IH} and V_{IL} rows • In section, PORST electrical specifications <ul style="list-style-type: none"> • In table, PORST electrical specifications: <ul style="list-style-type: none"> • Updated Unit and Min/Max values for V_{IH} and V_{IL} rows • In section, Input equivalent circuit and ADC conversion characteristics <ul style="list-style-type: none"> • In table, ADC conversion characteristics (for 12-bit): <ul style="list-style-type: none"> • Updated "ADC Analog Pad (pad going to one ADC)" row • In table, ADC conversion characteristics (for 10-bit): <ul style="list-style-type: none"> • Updated "ADC Analog Pad (pad going to one ADC)" row • In section, Analog Comparator (CMP) electrical specifications <ul style="list-style-type: none"> • In table, Comparator and 6-bit DAC electrical specifications: <ul style="list-style-type: none"> • Updated Min and Max values for V_{AO} to +47 mV • Updated Max Value for t_{DLS} to 21 μs
74		<ul style="list-style-type: none"> • In section, Main oscillator electrical characteristics <ul style="list-style-type: none"> • In table, Main oscillator electrical characteristics:

Table 51. Revision History (continued)

Rev. No.	Date	Substantial Changes
Rev 5.1	22 May 2017	<ul style="list-style-type: none"> • Removed the Introduction section from Section 4 "General". • In AC Specifications@3.3V section, removed note related to Cz results and added two notes. • In AC Specifications@5V section, added two notes. • In ADC Electrical Specifications section, added spec value of "ADC Analog Pad" at Max leakage (standard channel)@ 105 C T_A in "ADC conversion characteristics (for 10-bit)" table. • In PLL Electrical Specifications section, updated the first footnote of "Jitter calculation" table. • In Analog Comparator Electrical Specifications section, updated the TDLS (propagation delay, low power mode) max value in "Comparator and 6-bit DAC electrical specifications" table to 21 us. • In Recommended Operating Conditions section, updated the footnote link to T_A in "Recommended operating conditions (V_{DD_HV_x} = 5V)" table.